

**SLOVENSKI STANDARD**  
**SIST EN 61000-4-1:2007****01-oktober-2007****BUXca Yý U**  
**SIST EN 61000-4-1:2002**

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**Elektromagnetna združljivost (EMC) - 4-1. del: Preskusne in merilne tehnike - Pregled družine IEC 61000-4 (IEC 61000-4-1:2006)**

Electromagnetic compatibility (EMC) -- Part 4-1: Testing and measurement techniques - Overview of IEC 61000-4 series

Elektromagnetische Verträglichkeit (EMV) -- Teil 4-1: Prüf- und Messverfahren - Übersicht über die Reihe IEC 61000-4

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Compatibilité électromagnétique (CEM) -- Partie 4-1: Techniques d'essai et de mesure - Vue d'ensemble de la série IEC 61000-4

<https://standards.iteh.ai/standards/sist/69d37adc-d8ca-4335-abae-556acc78c697/sist-en-61000-4-1-2007>**Ta slovenski standard je istoveten z: EN 61000-4-1:2007****ICS:**33.100.01 Elektromagnetna združljivost Electromagnetic compatibility  
na splošno in general**SIST EN 61000-4-1:2007****en**

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English version

**Electromagnetic compatibility (EMC) -  
Part 4-1: Testing and measurement techniques -  
Overview of IEC 61000-4 series  
(IEC 61000-4-1:2006)**

Compatibilité électromagnétique (CEM) -  
Partie 4-1: Techniques d'essai  
et de mesure -  
Vue d'ensemble de la série CEI 61000-4  
(CEI 61000-4-1:2006)

Elektromagnetische Verträglichkeit  
(EMV) -  
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Übersicht über die Reihe IEC 61000-4  
(IEC 61000-4-1:2006)

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European Committee for Electrotechnical Standardization  
Comité Européen de Normalisation Electrotechnique  
Europäisches Komitee für Elektrotechnische Normung

**Central Secretariat: rue de Stassart 35, B - 1050 Brussels**

## Foreword

The text of document 77/319/FDIS, future edition 3 of IEC 61000-4-1, prepared by IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61000-4-1 on 2007-02-01.

This European Standard supersedes EN 61000-4-1:2000.

Changes introduced in EN 61000-4-1:2007 are for the purpose of updating the text to include reference to the latest publications of the EN 61000-4 series.

The following dates were fixed:

- latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2007-11-01
- latest date by which the national standards conflicting with the EN have to be withdrawn (dow) 2010-02-01

Annex ZA has been added by CENELEC.

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### Endorsement notice

The text of the International Standard IEC 61000-4-1:2006 was approved by CENELEC as a European Standard without any modification. (standards.iteh.ai)

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## Annex ZA (normative)

### Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60050-161	- <sup>1)</sup>	International Electrotechnical Vocabulary (IEV) - Chapter 161: Electromagnetic compatibility	-	-
IEC/TR 61000-1-1	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 1: General - Section 1: Application and interpretation of fundamental definitions and terms	-	-
IEC 61000-2-5	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 2: Environment - Section 5: Classification of electromagnetic environments	-	-
IEC 61000-3-2	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current ≤ 16 A per phase)	EN 61000-3-2	2006 <sup>2)</sup>
IEC 61000-3-3	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current ≤ 16 A per phase and not subject to conditional connection	EN 61000-3-3 + corr. July	1995 <sup>2)</sup> 1997
IEC/TS 61000-3-4	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3-4: Limits - Limitation of emission of harmonic currents in low-voltage power supply systems for equipment with rated current greater than 16 A	-	-
IEC/TS 61000-3-5 (mod)	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3: Limits - Section 5: Limitation of voltage fluctuations and flicker in low-voltage power supply systems for equipment with rated current greater than 16 A	-	-
IEC 61000-3-6	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3: Limits - Section 6: Assessment of emission limits for distorting loads in MV and HV power systems	-	-

<sup>1)</sup> Undated reference.

<sup>2)</sup> Valid edition at date of issue.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61000-3-11	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3-11: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems - Equipment with rated current $\leq 75$ A and subject to conditional connection	EN 61000-3-11	2000 <sup>2)</sup>
IEC 61000-3-12	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current $> 16$ A and $\leq 75$ A per phase	EN 61000-3-12	2005 <sup>2)</sup>
IEC 61000-4-2	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test	EN 61000-4-2	1995 <sup>2)</sup>
IEC 61000-4-3	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-3: Testing and measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test	EN 61000-4-3	2006 <sup>2)</sup>
IEC 61000-4-4	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test	EN 61000-4-4	2004 <sup>2)</sup>
IEC 61000-4-5	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test	EN 61000-4-5	2006 <sup>2)</sup>
IEC 61000-4-6	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields	-	-
IEC 61000-4-7	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-7: Testing and measurement techniques - General guide on harmonics and interharmonics measurements and instrumentation, for power supply systems and equipment connected thereto	EN 61000-4-7	2002 <sup>2)</sup>
IEC 61000-4-8	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test	EN 61000-4-8	1993 <sup>2)</sup>
IEC 61000-4-9	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-9: Testing and measurement techniques - Pulse magnetic field immunity test	EN 61000-4-9	1993 <sup>2)</sup>
IEC 61000-4-10	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-10: Testing and measurement techniques - Damped oscillatory magnetic field immunity test	EN 61000-4-10	1993 <sup>2)</sup>

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61000-4-11	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests	EN 61000-4-11	2004 <sup>2)</sup>
IEC 61000-4-12	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-12: Testing and measurement techniques - Ring wave immunity test	EN 61000-4-12	2006 <sup>2)</sup>
IEC 61000-4-13	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-13: Testing and measurement techniques - Harmonics and interharmonics including mains signalling at a.c. power port, low frequency immunity tests	EN 61000-4-13	2002 <sup>2)</sup>
IEC 61000-4-14	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-14: Testing and measurement techniques - Voltage fluctuation immunity test	EN 61000-4-14	1999 <sup>2)</sup>
IEC 61000-4-15	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-15: Testing and measurement techniques - Flickermeter - Functional and design specifications	EN 61000-4-15	1998 <sup>2)</sup>
IEC 61000-4-16	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-16: Testing and measurement techniques - Test for immunity to conducted, common mode disturbances in the frequency range 0 Hz to 150 kHz	EN 61000-4-16	1998 <sup>2)</sup>
IEC 61000-4-17	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-17: Testing and measurement techniques - Ripple on d.c. input power port immunity test	EN 61000-4-17	1999 <sup>2)</sup>
IEC 61000-4-18	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-18: Testing and measurement techniques - Oscillatory wave immunity test	-	-
IEC 61000-4-20	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-20: Testing and measurement techniques - Emission and immunity testing in transverse electromagnetic (TEM) waveguides	EN 61000-4-20	2003 <sup>2)</sup>
IEC 61000-4-21	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-21: Testing and measurement techniques - Reverberation chamber test methods	EN 61000-4-21	2003 <sup>2)</sup>
IEC 61000-4-23	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-23: Testing and measurement techniques - Test methods for protective devices for HEMP and other radiated disturbances	EN 61000-4-23	2000 <sup>2)</sup>
IEC 61000-4-24	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4: Testing and measurement techniques - Section 24: Test methods for protective devices for HEMP conducted disturbance	EN 61000-4-24	1997 <sup>2)</sup>

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61000-4-25	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-25: Testing and measurement techniques - HEMP immunity test methods for equipment and systems	EN 61000-4-25	2002 <sup>2)</sup>
IEC 61000-4-27	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-27: Testing and measurement techniques - Unbalance, immunity test	EN 61000-4-27	2000 <sup>2)</sup>
IEC 61000-4-28	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-28: Testing and measurement techniques - Variation of power frequency, immunity test	EN 61000-4-28	2000 <sup>2)</sup>
IEC 61000-4-29	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-29: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests	EN 61000-4-29	2000 <sup>2)</sup>
IEC 61000-4-30	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-30: Testing and measurement techniques - Power quality measurement methods	EN 61000-4-30	2003 <sup>2)</sup>
IEC/TR 61000-4-32	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-32: Testing and measurement techniques - High-altitude electromagnetic pulse (HEMP) simulator compendium	-	-
IEC 61000-4-33	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-33: Testing and measurement techniques - Measurement methods for high-power transient parameters	-	-
IEC 61000-4-34	- <sup>1)</sup>	Electromagnetic compatibility (EMC) - Part 4-34: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with input current more than 16 A per phase	-	-



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Third edition  
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PUBLICATION FONDAMENTALE EN CEM  
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**Compatibilité électromagnétique (CEM) –**

**Partie 4-1:**

**Techniques d'essai et de mesure –**

**Vue d'ensemble de la série CEI 61000-4**

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**Testing and measurement techniques –**  
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International Electrotechnical Commission, 3, rue de Varembe, PO Box 131, CH-1211 Geneva 20, Switzerland  
Telephone: +41 22 919 02 11 Telefax: +41 22 919 03 00 E-mail: [inmail@iec.ch](mailto:inmail@iec.ch) Web: [www.iec.ch](http://www.iec.ch)



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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ELECTROMAGNETIC COMPATIBILITY (EMC) –****Part 4-1: Testing and measurement techniques –  
Overview of IEC 61000-4 series**

## FOREWORD

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International Standard IEC 61000-4-1 has been prepared by IEC technical committee 77: Electromagnetic compatibility.

This standard forms Part 4-1 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This third edition cancels and replaces the second edition, published in 2000. It constitutes a technical revision. Changes introduced in this third edition are for the purpose of updating the text to include reference to the latest publications of the IEC 61000-4 series.